

Power MOSFET 40 V, 70 A, Single N-Channel, DPAK

Features

- Low R_{DS(on)}
- High Current Capability
- Low Gate Charge
- These are Pb-Free Devices

Applications

- Electronic Brake Systems
- Electronic Power Steering
- Bridge Circuits

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Paran	Symbol	Value	Unit		
Drain-to-Source Voltage			V _{DSS}	40	V
Gate-to-Source Voltage	е		V _{GS}	±20	V
Continuous Drain	Steady	T _C = 25°C	I _D	70	Α
Current – R _{θJC}	State	T _C = 125°C		40	
Power Dissipation – $R_{\theta JC}$	Steady State	T _C = 25°C	P _D	100	W
Continuous Drain	Steady State	T _A = 25°C	I _D	12.2	Α
Current – R _{θJA} (Note 1)	State	T _A = 125°C		7.0	
Power Dissipation – R _{θJA} (Note 1)	Steady State	T _A = 25°C	P _D	3.0	W
Pulsed Drain Current	t _p =	= 10 μs	I _{DM}	150	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to 175	°C
Source Current (Body Diode) Pulsed			Is	63.5	Α
Single Pulse Drain-to Source Avalanche Energy – (V_{DD} = 50 V, V_{GS} = 10 V, I_{PK} = 30 A, L = 1 mH, R_G = 25 Ω)			EAS	450	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T _L	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL RESISTANCE RATINGS (Note 1)

Parameter	Symbol	Max	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	1.5	°C/W
Junction-to-Case (Note 1)	$R_{\theta JA}$	49	

 Surface mounted on FR4 board using 1 sq in pad size, (Cu Area 1.127 sq in [2 oz] including traces).

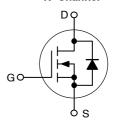


ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} TYP	I _D MAX (Note 1)
40 V	8.7 mΩ @ 10 V	70 A

N-Channel





MARKING DIAGRAM

1 YWW 54 06NG

Y = Year WW = Work Week 5406N = Specific Device Code G = Pb-Free Device

ORDERING INFORMATION

Device	Package	Shipping†
NTD5406NG	DPAK (Pb-Free)	75 Units / Rail
NTD5406NT4G	DPAK (Pb-Free)	2500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

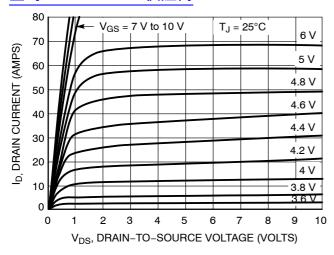
ZLEOTRICAL ACHARACTERISTICS (T_J = 25°C unless otherwise stated)

Parameter	Symbol	unless otherwise stated) Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•		<u>'</u>		•	1	· •
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				42		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 40 V	T _J = 25°C			1.0	μА
			T _J = 100°C			10	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{C}$	_{aS} = ±30 V			±100	nA
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{DS}$) = 250 μΑ	1.5		3.5	V
Gate Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-7.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V,	I _D = 30 A		8.7	10	mΩ
		V _{GS} = 5.0 V,	I _D = 10 A		13.2	17	
Forward Transconductance	9FS	V _{GS} = 10 V,	I _D = 10 A		19		S
CHARGES AND CAPACITANCES					-	=	
Input Capacitance	C _{ISS}				1375	2500	pF
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = V _{DS} = 3	1.0 MHz,		370	700	
Reverse Transfer Capacitance	C _{RSS}	• DS – S	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,		160	300	
Total Gate Charge	Q _{G(TOT)}				45		nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V. V	ne = 32 V.		2.0		1
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 10 \text{ V}, V_{DS} = 32 \text{ V},$ $I_{D} = 30 \text{ A}$			5.4		7
Gate-to-Drain Charge	Q_{GD}				20		
SWITCHING CHARACTERISTICS, Vo	as = 10 V (Note	3)					
Turn-On Delay Time	t _{d(ON)}				7.2		ns
Rise Time	t _r	V _{GS} = 10 V, V	_{nn} = 32 V,		57		
Turn-Off Delay Time	t _{d(OFF)}	$V_{GS} = 10 \text{ V, V}$ $I_D = 30 \text{ A, R}_0$	$_{\rm G} = 2.5 \Omega$		30		1
Fall Time	t _f				67		
SWITCHING CHARACTERISTICS, Vo	is = 5 V (Note 3)					
Turn-On Delay Time	t _{d(ON)}				15		ns
Rise Time	t _r	$V_{GS} = 5.0 \text{ V}, V_{DD} = 20 \text{ V},$ $I_{D} = 30 \text{ A}, R_{G} = 2.5 \Omega$			147		
Turn-Off Delay Time	t _{d(OFF)}				20		
Fall Time	t _f				29		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V, I _S = 10 A	T _J = 25°C		0.82	1.1	V
			T _J = 125°C		0.67		
Reverse Recovery Time	t _{RR}				46		ns
Charge Time	t _a	$V_{GS} = 0 \text{ V}, \text{ dI}_{SD}/\text{dt} = 100 \text{ A}/\mu\text{s}, \ I_{S} = 10 \text{ A}$			24		
Discharge Time	t _b				22		
Reverse Recovery Charge	Q _{RR}				65		nC

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

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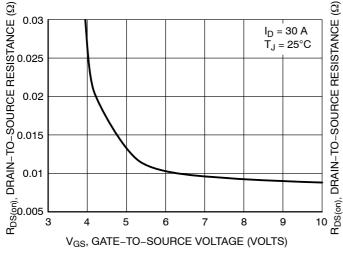
TYPICAL PERFORMANCE CURVES



 $V_{DS} \ge 10 \text{ V}$ 70 ID, DRAIN CURRENT (AMPS) 60 50 40 30 $T_J = 100^{\circ}C$ 20 $T_J = 25^{\circ}C$ 10 $T_J = -55^{\circ}C$ 0 0 5 8 6 V_{GS}, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



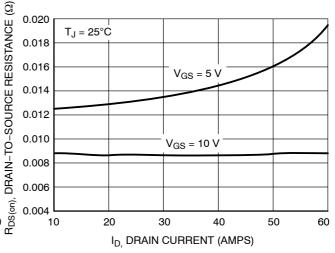
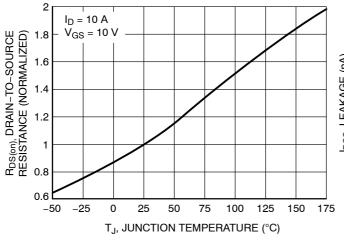


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



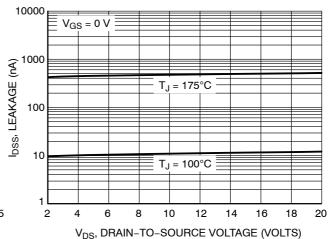
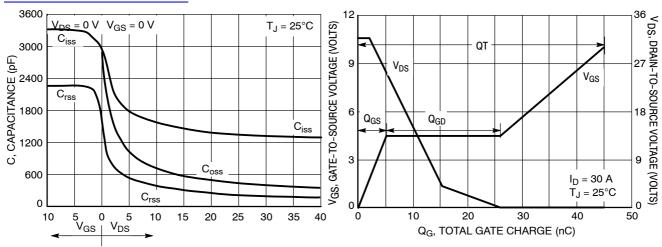


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

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TYPICAL PERFORMANCE CURVES



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

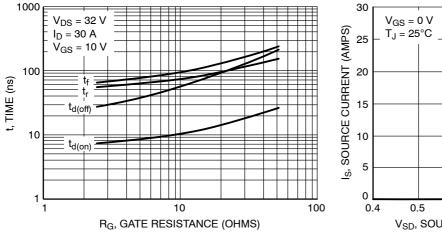


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

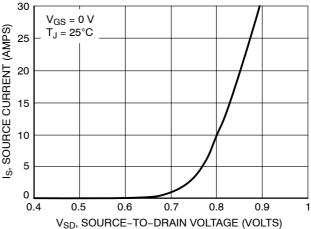


Figure 10. Diode Forward Voltage vs. Current

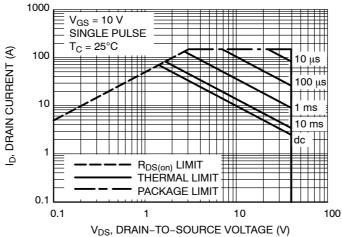


Figure 11. Maximum Rated Forward Biased Safe Operating Area

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TYPICAL PERFORMANCE CURVES

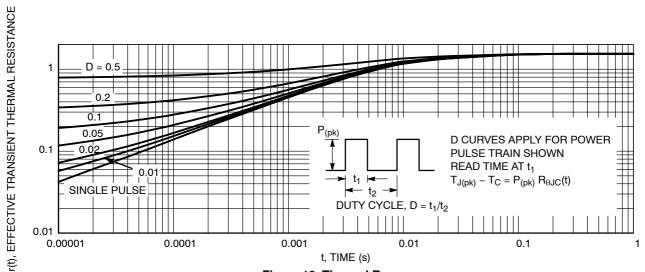


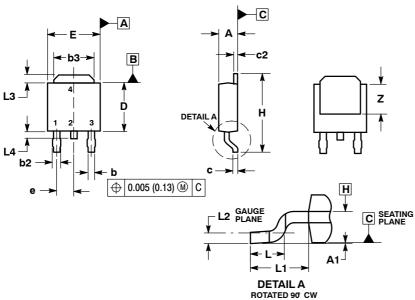
Figure 12. Thermal Response

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PACKAGE DIMENSIONS

DPAK (SINGLE GAUGE)

CASE 369C-01 ISSUE D

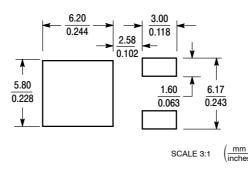


NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994
- 2. CONTROLLING DIMENSION: INCHES.
 3. THERMAL PAD CONTOUR OPTIONAL WITHIN
- DIMENSIONS b3, L3 and Z.
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
 5. DIMENSIONS D AND E ARE DETERMINED AT THE
- OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM

	INC	HES	MILLIN	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX		
Α	0.086	0.094	2.18	2.38		
A1	0.000	0.005	0.00	0.13		
b	0.025	0.035	0.63	0.89		
b2	0.030	0.045	0.76	1.14		
b3	0.180	0.215	4.57	5.46		
С	0.018	0.024	0.46	0.61		
c2	0.018	0.024	0.46	0.61		
D	0.235	0.245	5.97	6.22		
E	0.250	0.265	6.35	6.73		
е	0.090	0.090 BSC		2.29 BSC		
Н	0.370	0.410	9.40	10.41		
L	0.055	0.070	1.40	1.78		
L1	0.108 REF		2.74	REF		
L2	0.020 BSC		0.51	1 BSC		
L3	0.035	0.050	0.89	1.27		
L4		0.040		1.01		
Z	0.155		3.93			

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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